Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/506,355	KOSUGI ET AL.	
Examiner	Art Unit	

David M. Fenstermacher

3682

	SEARCHED				
Class	Subclass	Date	Examiner		
184	6.14				
	27.1				
384	473				
	471				
	475				
417	490	5/10/2007	DMF		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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